IN THE CLAIMS:

(Currently amended) A circuit comprising:

a plurality of trim tracking links coupled in series;

a plurality of detecting [[devices]] <u>diodes</u> wherein each detecting [[device]] <u>diode</u> is coupled in parallel with a corresponding trim tracking link; [[and]]

a probe pad coupled to the string of trim tracking links; and

a calibration diode device coupled in parallel with the plurality of trim tracking links.

2-4. (Canceled)

- 5. (Currently amended) The circuit of claim [[4]] 1 wherein the calibration diode device comprises at least one diode.
- (Currently amended) The circuit of claim [[4]] 1 wherein the calibration diode device comprises a plurality of diodes coupled in series, and coupled in parallel with the plurality of trim tracking links.

7 and 8. (Canceled)

(Currently amended) A circuit for detecting and tracking a status of a device under laser trim comprising:

a series connected string of trim tracking links; and

a plurality of detecting [[devices]] <u>diodes</u> wherein each detecting [[device]] <u>diode</u> is coupled in parallel with a corresponding trim tracking link; <u>and</u>

a plurality of calibration diodes coupled in series, and coupled in parallel with the series connected string of trim tracking links.

10-15. (Canceled)

16. (Original) A circuit for detecting and tracking a status of a device under laser trim comprising:

at least two trim tracking links coupled in series; and

at least two trim tracking diodes wherein each trim tracking diode is coupled in parallel with a corresponding trim tracking link; and

a calibration diode device coupled in parallel with the at least two trim tracking links.

- (Original) The circuit of claim 16 wherein the calibration diode device comprises at least one diode.
- 18. (Original) The circuit of claim 16 wherein the calibration diode device comprises a plurality of calibration diodes coupled in series, and coupled in parallel with the at least two trim tracking links.